

<b>Notice of References Cited</b>	Application/Control No. 10/579,404		Applicant(s)/Patent Under Reexamination RIDDINGTON ET AL.	
	Examiner ZEWDU BEYEN		Art Unit 2419	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,892,802 A	04-1999	Jung et al.	375/354
*	B	US-5,920,545 A	07-1999	Rasanen et al.	370/232
*	C	US-6,138,020 A	10-2000	Galyas et al.	455/436
*	D	US-2002/0164992 A1	11-2002	Olsen, James J.	455/452
*	E	US-6,532,236 B1	03-2003	De Vriendt, Johan Andre	370/395.1
*	F	US-2003/0067893 A1	04-2003	DUPUY et al.	370/329
*	G	US-6,636,497 B1	10-2003	Honkasalo et al.	370/335
*	H	US-6,647,006 B1	11-2003	Rasanen, Juha	370/345
*	I	US-6,721,304 B1	04-2004	Rasanen, Juha	370/347
*	J	US-6,782,367 B2	04-2004	Vainio et al.	704/500
*	K	US-2005/0018769 A1	01-2005	Hellwig et al.	375/240.12
*	L	US-6,879,599 B1	04-2005	Galyas et al.	370/466
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.